

**Calibration Laboratory of**  
Schmid & Partner  
Engineering AG  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

**Glossary:**

NORM <sub>x,y,z</sub>	sensitivity in free space
DCP	diode compression point
Polarization $\varphi$	$\varphi$ rotation around probe axis
Polarization $\vartheta$	$\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASy system to align probe sensor X to the robot coordinate system

**Calibration is Performed According to the Following Standards:**

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

**Methods Applied and Interpretation of Parameters:**

- NORM<sub>x,y,z</sub>**: Assessed for E-field polarization  $\vartheta = 0$  for XY sensors and  $\vartheta = 90$  for Z sensor ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide).
- NORM(f)<sub>x,y,z</sub>** = NORM<sub>x,y,z</sub> \* frequency\_response (see Frequency Response Chart).
- DCP<sub>x,y,z</sub>**: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM<sub>x</sub> (no uncertainty required).



ER3DV6 SN:2358

January 28, 2008

# Probe ER3DV6

## SN:2358

Manufactured:	July 7, 2005
Last calibrated:	February 21, 2007
Recalibrated:	January 28, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)



ER3DV6 SN:2358

January 28, 2008

**DASY - Parameters of Probe: ER3DV6 SN:2358**

Sensitivity in Free Space [ $\mu\text{V}/(\text{V}/\text{m})^2$ ]

Diode Compression<sup>A</sup>

NormX      **1.70 ± 10.1 % (k=2)**  
NormY      **1.55 ± 10.1 % (k=2)**  
NormZ      **1.61 ± 10.1 % (k=2)**

DCP X      **92 mV**  
DCP Y      **92 mV**  
DCP Z      **96 mV**

Frequency Correction

X                      **0.0**  
Y                      **0.0**  
Z                      **0.0**

Sensor Offset

(Probe Tip to Sensor Center)

X                      **2.5 mm**  
Y                      **2.5 mm**  
Z                      **2.5 mm**

Connector Angle

**-243 °**

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> numerical linearization parameter: uncertainty not required

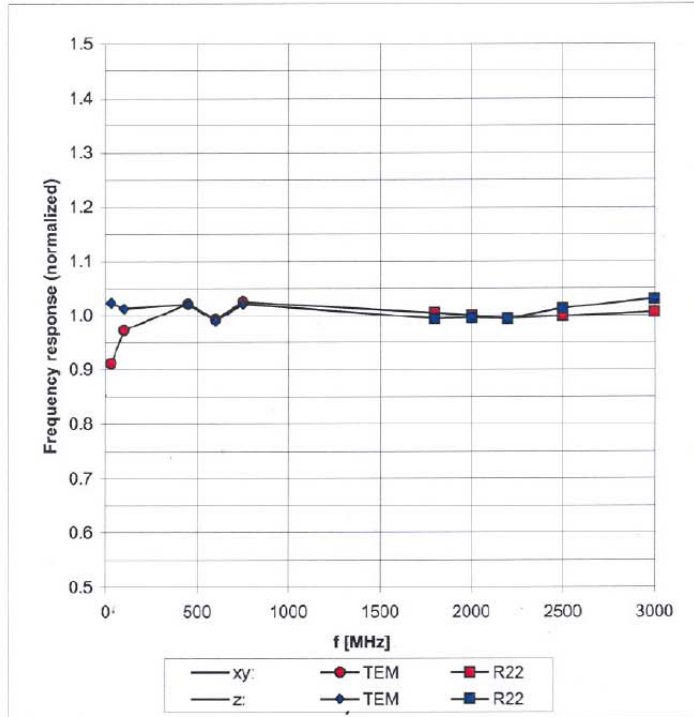


ER3DV6 SN:2358

January 28, 2008

### Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)



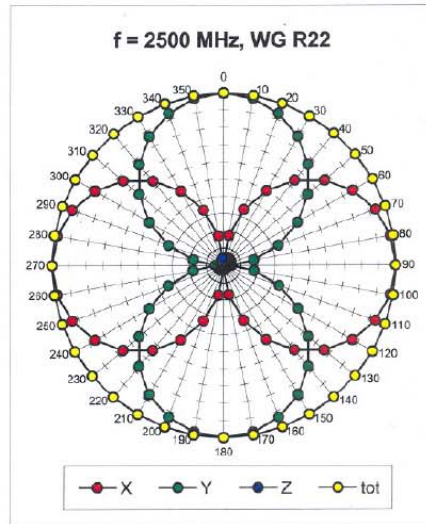
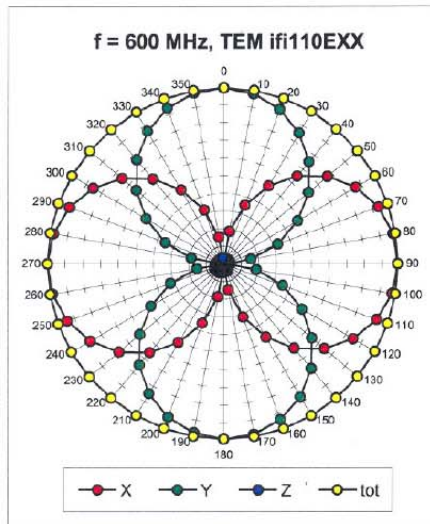
Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)



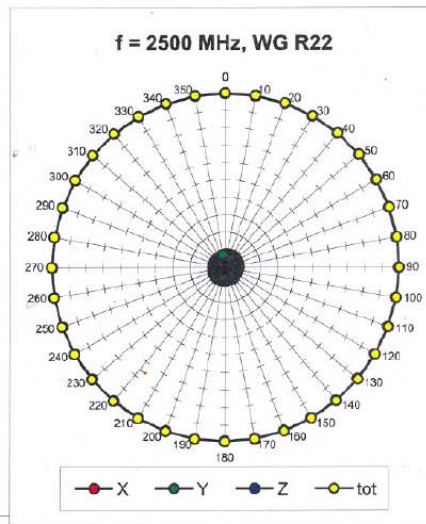
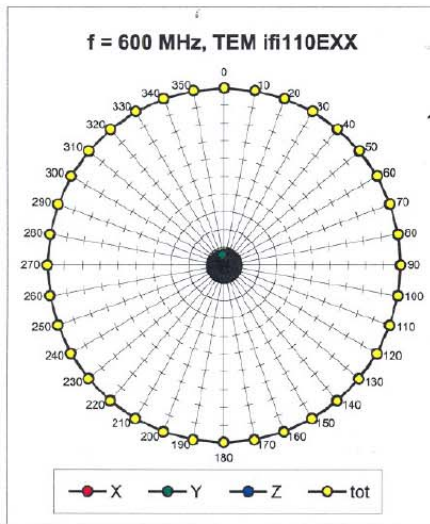
ER3DV6 SN:2358

January 28, 2008

### Receiving Pattern ( $\phi$ ), $\vartheta = 0^\circ$



### Receiving Pattern ( $\phi$ ), $\vartheta = 90^\circ$

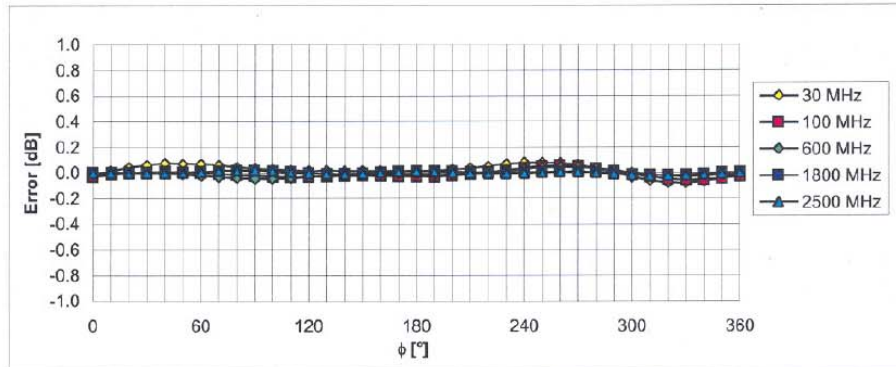




ER3DV6 SN:2358

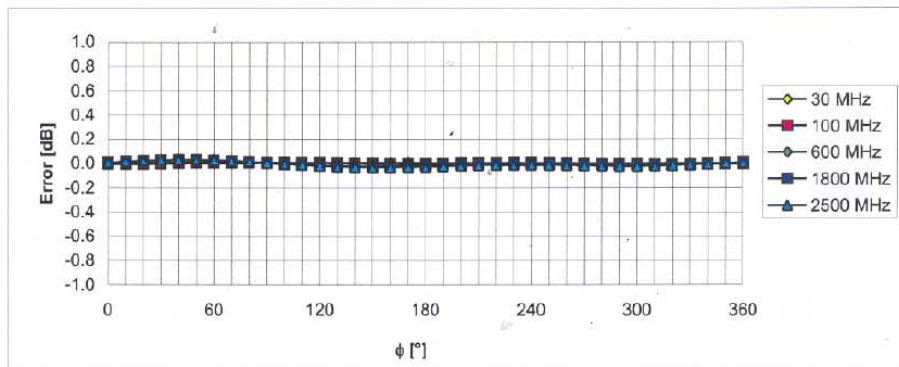
January 28, 2008

### Receiving Pattern ( $\phi$ ), $\vartheta = 0^\circ$



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )

### Receiving Pattern ( $\phi$ ), $\vartheta = 90^\circ$



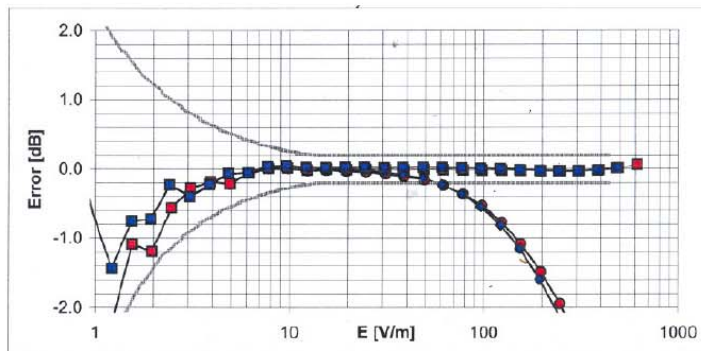
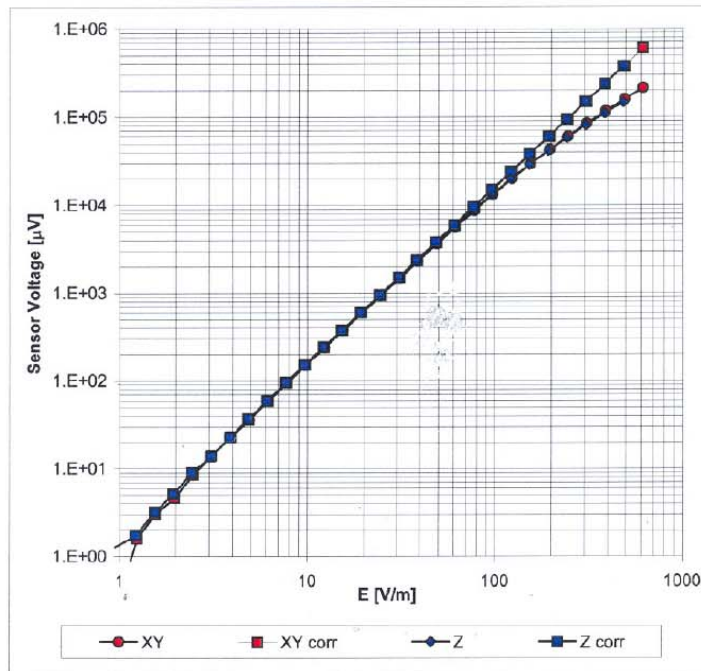
Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )



ER3DV6 SN:2358

January 28, 2008

### Dynamic Range f(E-field) (Waveguide R22, f = 1800 MHz)



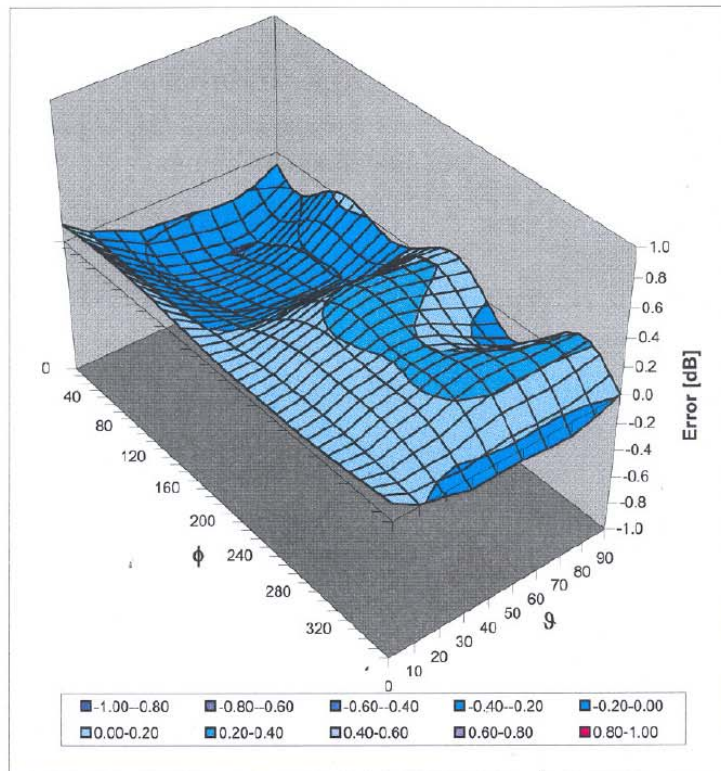
Uncertainty of Linearity Assessment:  $\pm 0.6\%$  (k=2)



ER3DV6 SN:2358

January 28, 2008

### Deviation from Isotropy in Air Error ( $\phi, \theta$ ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  ( $k=2$ )





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Accreditation No.: SCS 108

Client Sporton (Auden)

Certificate No: H3-6184\_Jan08

CALIBRATION CERTIFICATE

Object: H3DV6 - SN:6184
Calibration procedure(s): QA CAL-03.v5
Calibration procedure for H-field probes optimized for close near field evaluations in air
Calibration date: January 28, 2008
Condition of the calibrated item: In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 +/- 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Primary Standards, ID #, Cal Date (Calibrated by, Certificate No.), Scheduled Calibration. Lists various power meters, sensors, attenuators, and probes with their respective IDs and calibration dates.

Table with 4 columns: Secondary Standards, ID #, Check Date (in house), Scheduled Check. Lists RF generator and Network Analyzer with their IDs and in-house check dates.

Calibrated by: Katja Pokovic, Technical Manager
Approved by: Niels Kuster, Quality Manager

Issued: January 28, 2008

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.



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**Methods Applied and Interpretation of Parameters:**

- $X, Y, Z_{a0a1a2}$ : Assessed for E-field polarization  $\vartheta = 90$  for XY sensors and  $\vartheta = 0$  for Z sensor ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide).
- $X, Y, Z(f)_{a0a1a2} = X, Y, Z_{a0a1a2} * frequency\_response$  (see Frequency Response Chart).
- $DCP_{x,y,z}$ : DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy)*: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle*: The angle is assessed using the information gained by determining the  $X_{a0a1a2}$  (no uncertainty required).



H3DV6 SN:6184

January 28, 2008

# Probe H3DV6

## SN:6184

Manufactured:	June 8, 2004
Last calibrated:	February 21, 2007
Recalibrated:	January 28, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)



H3DV6 SN:6184

January 28, 2008

**DASY - Parameters of Probe: H3DV6 SN:6184**

Sensitivity in Free Space [A/m /  $\sqrt{\mu\text{V}}$ ]

	a0	a1	a2
X	2.409E-03	6.763E-5	-9.365E-6 ± 5.1 % (k=2)
Y	2.502E-03	-4.500E-5	-8.887E-6 ± 5.1 % (k=2)
Z	2.915E-03	-3.422E-5	4.661E-5 ± 5.1 % (k=2)

Diode Compression<sup>1</sup>

DCP X	84 mV
DCP Y	84 mV
DCP Z	85 mV

Sensor Offset (Probe Tip to Sensor Center)

X	3.0 mm
Y	3.0 mm
Z	3.0 mm

Connector Angle -244 °

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>1</sup> numerical linearization parameter: uncertainty not required

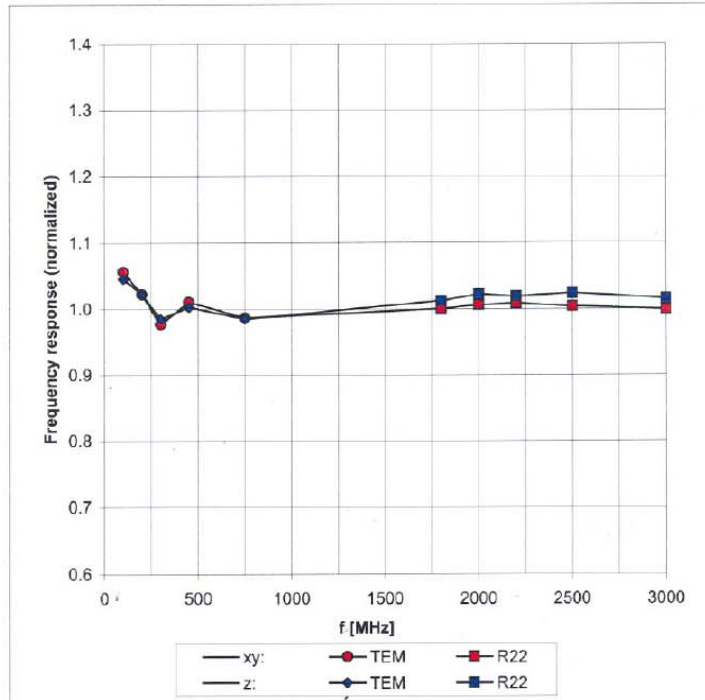


H3DV6 SN:6184

January 28, 2008

### Frequency Response of H-Field

(TEM-Cell:ifi110, Waveguide R22)



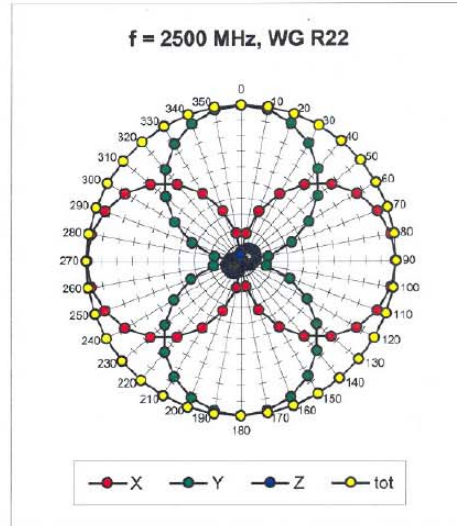
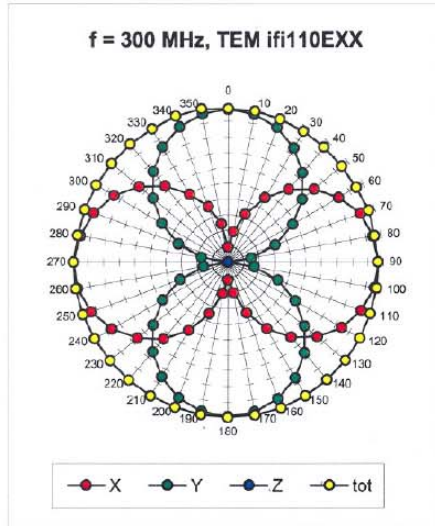
Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  ( $k=2$ )



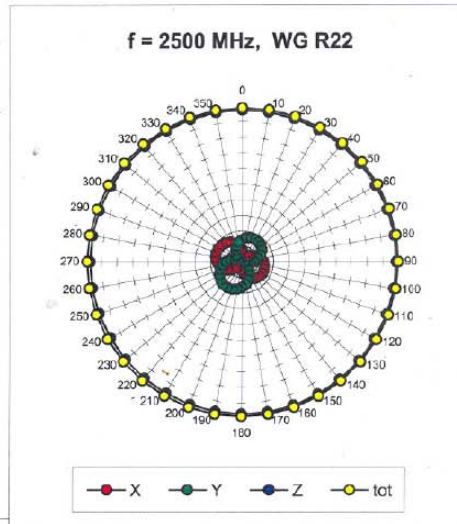
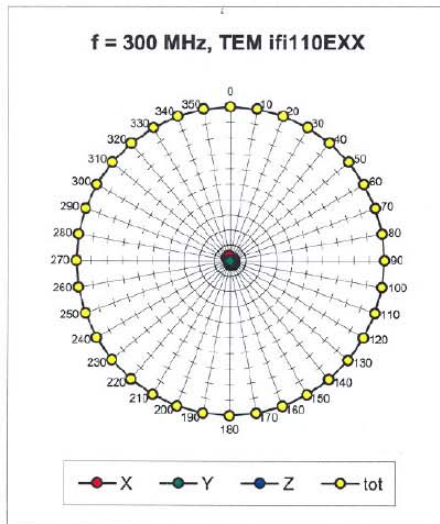
H3DV6 SN:6184

January 28, 2008

Receiving Pattern ( $\phi$ ),  $\vartheta = 90^\circ$



Receiving Pattern ( $\phi$ ),  $\vartheta = 0^\circ$

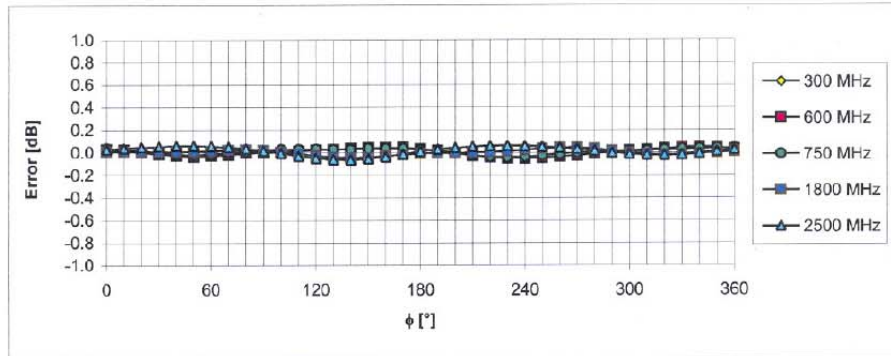




H3DV6 SN:6184

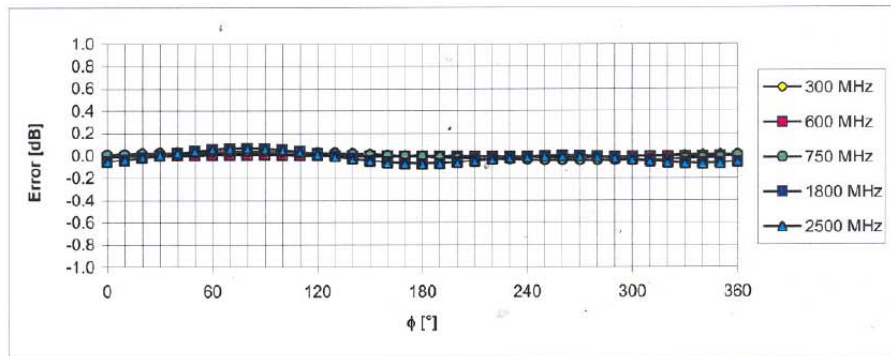
January 28, 2008

### Receiving Pattern ( $\phi$ ), $\vartheta = 90^\circ$



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )

### Receiving Pattern ( $\phi$ ), $\vartheta = 0^\circ$



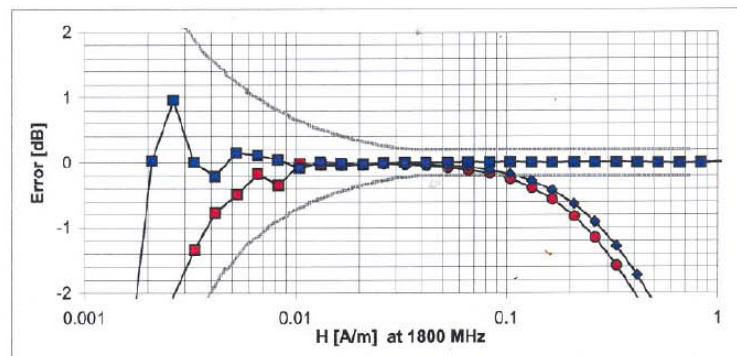
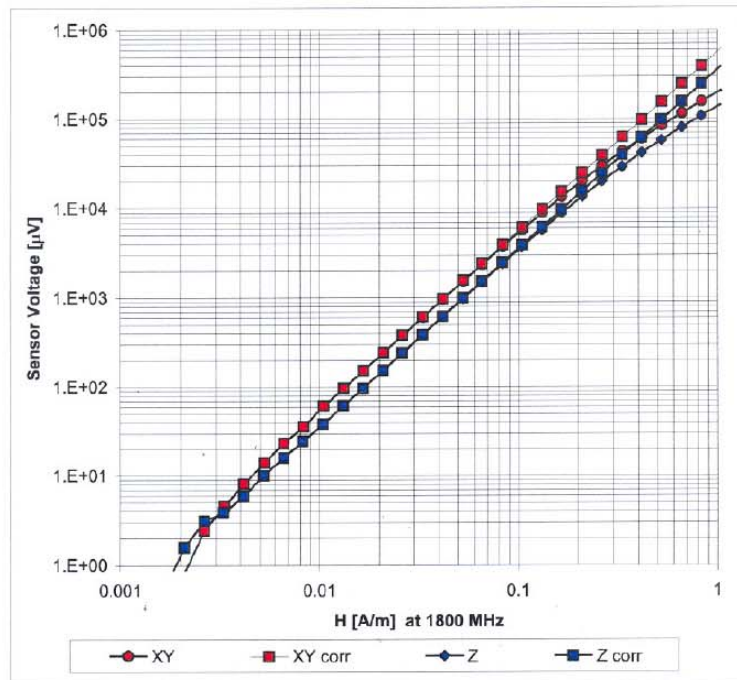
Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )



H3DV6 SN:6184

January 28, 2008

### Dynamic Range f(H-field) (Waveguide R22, f = 1800 MHz)

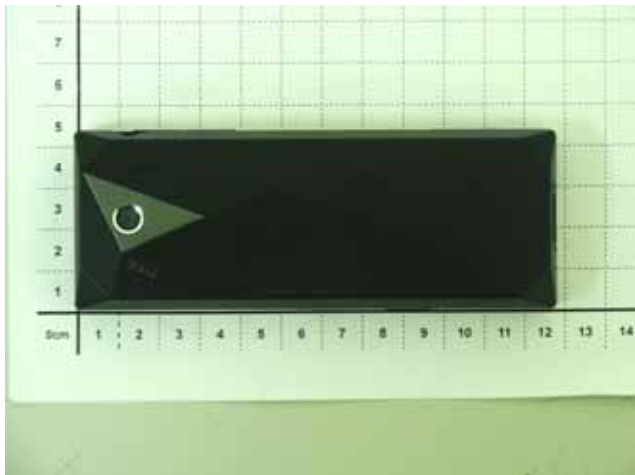
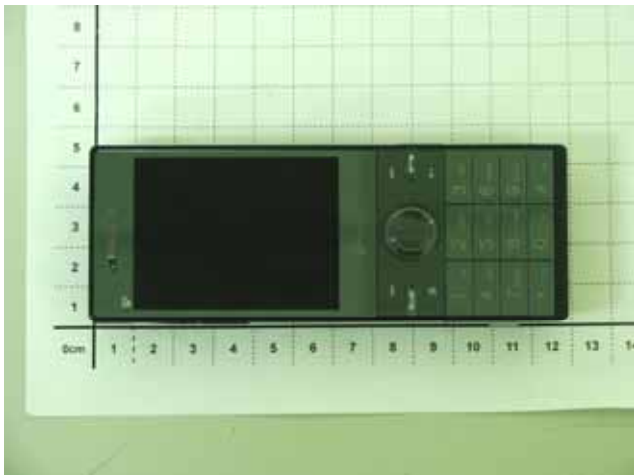


Uncertainty of Linearity Assessment:  $\pm 0.6\%$  (k=2)





Appendix D - Product Photographs



**Appendix E - Setup Photographs**



**Front View for DUT Slide Off**



**Right Side View for DUT Slide Off**



**Left Side View for DUT Slide Off**



**Front View for DUT Slide Right**



**Right Side View for DUT Slide Right**



**Left Side View for DUT Slide Right**